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PATENT & TRADEMARK OFFICE

Form PTO 1449
(Modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

217954US0

SERIAL NO.

10/035,123

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Takaharu et al.

FILING DATE

January 4, 2002

GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
MC	AA	6,184,288	2/6/01	Ninomiya et al.			
MC	AB	3,847,845	11/12/74	Rentaro TADA, et al.			
MC	AC	5,118,743	6/2/92	Yorjezu et al. (Equivalent to JP 64-66262)			
MC	AD	5,146,822	9/15/92	Noda et al. (equivalent to JP 3-61507)			
MC	AE	5,322,866	6/21/94	Mayer et al.			
	AF						
	AG						
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	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
MC	AO	JP 64-66262	9/7/87	JAPAN (equivalent to US 5,118,743)		x
MC	AP	JP 55012108 A	1/28/80	JAPAN (with English Abstract)		x
MC	AQ	JP 57034148 A	2/24/82	JAPAN (with English Abstract)		x
MC	AR	JP 3-61507	3/18/91	JAPAN (equivalent to US 5,146,822)		x
MC	AS	EP 0 892 006 A2	7/16/98	EUROPE	x	
MC	AT	JP 11058500 A	3/2/99	JAPAN (with English Abstract)		x
MC	AU	JP 11058501 A	3/2/99	JAPAN (with English Abstract)		x
MC	AV	WO99/05213	4/2/99	WIPO (equivalent to EP 0 930 339 A1)	x	

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

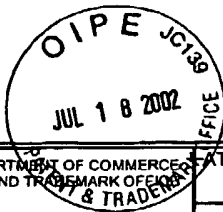
Examiner

M. E. Carter

Date Considered

29/Apr/04

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U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
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	AD						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
MC	AO	1 179 546	02/13/2002	EUROPE		
MC	AP	1 072 616	01/31/2001	EUROPE		
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

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